





Available Measurement Ranges

WR7-30 Standard (VIS)	330 – 1180 nm
WR7-30 UV-I	248 – 1180 nm
WR7-30 IR-I	630 – 1750 nm

Absolute (and Other) Accuracies 1)

248 – 330 nm (with multi mode fiber)	0.1 pm
330 – 375 nm	50 MHz
375 – 800 nm	30 MHz
800 - 1180 nm	25 MHz
1180 – 2250 nm	20 MHz
Quick coupling accuracy (with 50 μm multi mode fiber)	100 MHz
Wavelength deviation sensitivity/Measurement resolution ²⁾	1 MHz
Linewidth estimation accuracy 3) 4)	200 MHz

Measurement Speed

500 Hz

- 1) According to 3σ criterion, but never better than 20 % of the laser linewidth.
- 2) Standard deviation. WR7-30 requires photonic crystal (endlessly singlemode) fibers to reach this resolution.
- 3) Not better than 20% of the linewidth.
- 4) Each instrument in each mode can measure lasers with a linewidth up to 30 % of the correspondig FSR.









Required Minimum Input Energy and Power⁵⁾

Standard (VIS)	0.08 – 60 μJ or μW
UV-I	0.08 – 40 μJ or μW
IR-I	8 – 800 μJ or μW

FSR of the Fizeau Interferometers (Fine/Wide Mode)

4 GHz/32 GHz 4)

Calibration

Stabilized HeNe Rack laser, SLR-1532 Rack, or any other well known laser source $\Delta v < 5$ MHz

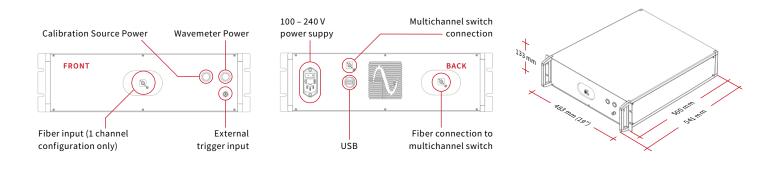
Recommended calibration period ≤ 10 hour

Warm-up Time

> 30 min. warm-up, or until ambient equilibrium

Dimensions L × W × H 6)

541 × 483 × 133 mm



- 4) Each instrument in each mode can measure lasers with a linewidth up to 30 % of the correspondig FSR.
- 5) The CW power interpretation in $[\mu W]$ compares to an exposure of 1s (generally the energy needs to be divided by the exposure time to obtain the required power).
- 6) Dimensions with handles.









Weight		
16 kg		
Interface		
Control	High-speed USB 2.0 connection	
External Trigger	BNC	
Power Supply		
100 – 240 V ~ 50/60 Hz 80 W		
Included Options		
External Trigger (TTL)		
pulsed measurements externally. The TTL option	ed signals automatically. Additionally, this option allows the user to trigger n guarantees synchronization between pulsed excitation and measurement. arts when measuring pulsed signals with low duty cycles.	
Please note, if the option MC is ordered together to one input channel.	with the TTL option, the TTL mode can only be used if the switch is set fixed	
Ontions		

Laser Control (PID)

With the PID option it is possible to stabilize the frequency of a laser connected to the wavelength meter using a software based proportional-integral-derivative controller (PID controller). Unlike analog PID electronics, the PID option provides software based signal processing, allowing the laser to be stabilized to a specific user defined frequency or regulated with an arbitrary pattern.

This makes it extremely useful in experiments where the laser frequency has to be actively regulated or varied to fit changing experimental conditions, such as laser cooling, atomic detection, trapping and spectroscopy.

Combined with the MC option the wavelength meter can be used to stabilize multiple lasers simultaneously. The regulation speed, quality and absolute accuracy match the measurement speed, relative accuracy and absolute accuracy of the wavelength meter respectively. The measurement speed is not affected by the regulation.









Options

Photonic Crystal Switch Rack

In order to measure the frequencies of more than just one laser at a time, an opto-mechanical switch is used. The combination of our high-speed wavelength meters with one of the quickest fiber switches (MEMS) available allows up to eight channels to be measured almost simultaneously. Exposure time and other parameters can be defined independently for each light source.

The WR7-30 series features the use of an endlessly singlemode switch based on the photonic crystal switch technology in an external 19", 1 HU rack. This allows to measure any laser wavelength on all switch input channels within all measurement ranges.

Please note, if the option MC is ordered together with the TTL option, the TTL mode can only be used if the switch is set fixed to one input channel.

Linewidth Estimation (L)

The linewidth estimation of a singlemode laser source is performed by a special algorithm which eliminates the interferometer's instrument response function. The algorithm enables the estimation of the linewidth with an accuracy better than the tenth of the instrument FSR.

The linewidth option can also be used for measuring the linewidth of multimode lasers or lasers with sidebands. In this case, the longitudinal mode splitting needs to be less than the instruments spectral resolution and the calculated result is the FWHM of the envelope function of the multiline spectrum. Any instrument can be upgraded with the L-option.

Singlemode fibers are required.

External Calibration (CAL)

We recommend the calibration sources SLR-1532 Rack or HeNe Rack depending on the range of interest. Both are built in an external 3 HU Rack (options for integration in Wavemeter Rack available as well).

For further information see our product description here: https://www.highfinesse.de/cal









Typical Applications

The WR7-30 series offers an accuracy of 30 MHz. It is dedicated to wavelength monitoring and wavelength control with the wavelength deviation sensitivity of 1 MHz. In order to monitor and control complex laser systems, it perfectly combines with the photonic crystal fiber technology enabling multichannel operation in the entire spectral range of the wavelength meter.

The absolute 30 MHz accuracy is reached, when the wavelength meter is combined with one of our calibration sources or any suitable frequency reference provided by the user.

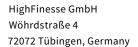
Further Information

For further technical information, application examples, diagrams and for customization of the WR7-30 series please contact:

HighFinesse Team

service@highfinesse.de

















Additional information and distributors: www.highfinesse.com









